

<b>Notice of References Cited</b>	Application/Control No. 10/574,806	Applicant(s)/Patent Under Reexamination FUJINAGA ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0234830	11-2004	Draper et al.	429/030
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 11025999 A	01-1999	Japan	SHIGEHISA, TAKASHI	H01M 8/02
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**NON-PATENT DOCUMENTS**

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